

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	Page 1 of 1
	Mark John Stevenosky, Jr.	2853	

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*	C	US-6,368,515	04-2002	Kaminishi et al.	216/27
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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